

INITIAL PRODUCT/PROCESS CHANGE NOTIFICATION Generic Copy

31 Jan 2008

SUBJECT: ON Semiconductor Initial Product/Process Change Notification #16091

TITLE: Copper Wire replacing Gold Wire in the SO8, TSOP6, ChipFET Packages for MOSFET Products

PROPOSED FIRST SHIP DATE: 31 May 2008

AFFECTED CHANGE CATEGORY: ON Semiconductor SO8, TSOP6, ChipFET Assembly Areas – Wire Bond

AFFECTED PRODUCT DIVISION: PowerFET Business Unit

FOR ANY QUESTIONS CONCERNING THIS NOTIFICATION: Contact your local ON Semiconductor Sales Office or Tom Huettl <<u>Tom.Huettl@onsemi.com</u>>

NOTIFICATION TYPE:

Initial Product/Process Change Notification (IPCN)

First change notification sent to customers. IPCNs are issued at least 120 days prior to implementation of the change. An IPCN is advance notification about an upcoming change and contains general information regarding the change details and devices affected. It also contains the preliminary reliability qualification plan.

The completed qualification and characterization data will be included in the Final Product/Process Change Notification (FPCN).

This IPCN notification will be followed by a Final Product/Process Change Notification (FPCN) at least 90 days prior to implementation of the change.

DESCRIPTION AND PURPOSE:

ON Semiconductor is notifying customers of its plan to qualify Copper Wire (in place of Gold Wire) on their MOSFET Products in the SO8, ChipFET, and TSOP6 Packages. Products for both the Planar and Silicon platforms will be affected.

The mold compound, die attach, and lead frame materials used for each of the 3-Packages will not be changed. Reliability Qualification and full electrical characterization over temperature will be performed for each of the Packages and Silicon platforms.

Multiple Final PCN's will be published upon the successful completion of both the Package and Silicon qualification and electrical characterization. Each of the Final PCN's will list all the Devices being released, and the Date Code of products which will contain Copper Wire instead of Gold.



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QUALIFICATION PLAN:

SO8, TSOP6, ChipFET Packages with Qualification Samples from both Planar and Trench Silicon platforms being tested

Test: High Temperature Reverse Bias (HTRB) Conditions: Vds= 80% Vds rating, Ta=150'C, 504-Hrs Results: 0/240

Test: High Temperature Gate Bias (HTGB) Conditions: Vgs= 100%Vgs, Ta=150'C, 504-Hrs. Results: 0/240

Test: Intermittent Operating Life (IOL-PC) Conditions: Ta=+25'C, delta Tj=100'C, 2-min on/off, 7.5K-cycles Results: 0/240

Test: Temperature Cycling (TC-PC) Conditions: Ta=-65'C/+150'C, Air-to-Air, Dwell >=10-min, 500-cy Results: 0/240

Test: Highly Accelerated Stress Test (HAST-PC) Conditions: Ta=130'C, RH=85%, P=18.8psig, 96-Hrs Results: 0/240

Test: Highly Accelerated Stress Test (HAST-PC) Conditions: Ta=121'C, RH=100%, P=15psig, 96-Hrs Results: 0/240

Test: Full Electrical Distribution Data

AFFECTED DEVICE LIST:

PART

NTHS2101PT1 NTHS4101PT1G NTHS2101PT1G NTHS4101PT1 NTHS4111PT1G NTHS4111PT1 NTHS4166NT1G NTHS4501NT1G NTHS4501NT1 NTHS5404T1G NTHS5404T1H NTHS5404T1 NTHS5441T1G NTHS5441T1 NTHS5443T1G NTHS5443T1H NTHS5443T1 NTHD2102PT1G NTHD2102PT1 NTHD3100CT1G



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NTHD3100CT1 NTHD3100CT3 NTHD3101FT1G NTHD3101FT1 NTHD3102CT1G NTHD3133PFT1G NTHD3133PFT3G NTHD3138FT1G NTHD4102PT1G NTHD4102PT1 NTHD4102PT3G NTHD4401PT1G NTHD4401PT3G NTHD4502NT1G NTHD4502NT1 NTHD4508NT1G NTHD4508NT1 NTHD4N02FT1G NTHD4N02FT1 NTHD4P02FT1G NTHD4P02FT1 NTHD5903T1G NTHD5903T1 NTHD5904NT1G NTHD5904NT1 MMSF3P02HDR2 MMSF3P02HDR2 MMSF3P02HDR2 MMSF3P02HDR2 MMSF3P02HDR2G MMSF3P02HDR2G MMSF3P02HDR2SG MMSF3P02HDR2SG MMSF7P03HDR2 MMSF7P03HDR2 MMSF7P03HDR2 MMSF7P03HDR2 MMSF7P03HDR2G MMSF7P03HDR2G NTMS10P02R2 NTMS10P02R2G NTMS3P03R2 NTMS3P03R2G NTMS4107NR2 NTMS4107NR2G NTMS4404NR2 NTMS4503NR2 NTMS4503NR2G NTMS4700NR2 NTMS4700NR2G NTMS4704NR2 NTMS4704NR2G NTMS4705NR2 NTMS4705NR2G NTMS4706NR2 NTMS4706NR2G



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NTMS4807NR2G NTMS4816NR2G NTMS4N01R2 NTMS4N01R2G NTMS5P02R2 NTMS5P02R2G NTMS5P02R2SG NTMS7N03R2 NTMS7N03R2G NTMS4807NR2G NTMS4816NR2G NTMS4176PR2G NTMS4177PR2G NTMS4872NR2G MMDF1N05ER2 MMDF1N05ER2G MMDF2C03HDR2 MMDF2C03HDR2G MMDF2N02ER2 MMDF2N02ER2G MMDF2P02ER2 MMDF2P02ER2G MMDF2P02HDR2 MMDF2P02HDR2G MMDF3N02HDR2 MMDF3N02HDR2G MMDF3N04HDR2 MMDF3N04HDR2G NTMD2C02R2 NTMD2C02R2G NTMD2C02R2SG NTMD2P01R2 NTMD2P01R2G NTMD3N08LR2 NTMD3P03R2 NTMD3P03R2G NTMD4820NR2G NTMD4840NR2G NTMD4N03R2 NTMD4N03R2G NTMD6601NG NTMD6601NR2G NTMD6N02R2 NTMD6N02R2G NTMD6N03R2 NTMD6N03R2G NTMD6N04R2G NTMD6P02R2 NTMD6P02R2G NTMD6P02R2SG SMDF2C03HDR2 NTMD4820NR2G NTMD4840NR2G NTMD4184PFR2G NTMD4884NFR2G NTMS4873NFR2G



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NTMSD2P102LR2G NTMSD2P102R2 NTMSD2P102R2SG NTMSD3P102R2 NTMSD3P102R2G NTMSD3P102R2SG NTMSD3P303R2 NTMSD3P303R2G NTMSD6N303R2 NTMSD6N303R2G NTMSD6N303R2SG NTGS3130NT1G NTGS3136PT1G NTGS3433T1G NTGS3433T1 NTGS3441BT1G NTGS3441PT1G NTGS3441T1G NTGS3441T1H NTGS3441T1 NTGS3441T1 NTGS3443BT1G NTGS3443T1G NTGS3443T1H NTGS3443T1 NTGS3443T2G NTGS3443T2H NTGS3446T1G NTGS3446T1 NTGS3447PT1G NTGS3455T1G NTGS3455T1H NTGS3455T1 NTGS4111PT1G NTGS4111PT1 NTGS4111PT2G NTGS4141NT1G NTGS4141NT1 NTGD1100LT1G NTGD1100LT1 NTGD3122CT1G NTGD3133PT1G NTGD4161PT1G